

N-Channel Enhancement Mosfet

General Description

- Low $R_{DS(ON)}$
- RoHS and Halogen-Free Compliant

Applications

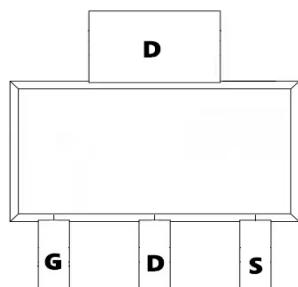
- Load switch
- PWM

General Features

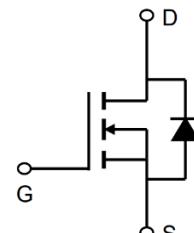
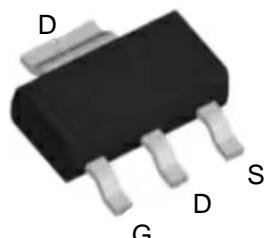
$V_{DS} = 100V$ $I_D = 10A$

$R_{DS(ON)} = 75\text{ m}\Omega$ (typ.) @ $V_{GS}=10V$

100% UIS Tested
100% R_g Tested



MSI:SOT-223-3L



Marking:10N10

Absolute Maximum Ratings: ($T_A=25^\circ C$ unless otherwise noted)

Symbol	Parameter	Ratings	Units
V_{DS}	Drain-Source Voltage	100	V
V_{GS}	Gate-Source Voltage	± 20	V
I_D	Continuous Drain Current ¹	10	A
	Continuous Drain Current- $T_A=70^\circ C$ ¹	4	
I_{DM}	Pulsed Drain Current ²	24	
P_D	Power Dissipation ⁴	2.5	W
E_{AS}	Single pulse avalanche energy ³	10.1	mJ
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55-+150	°C

Thermal Characteristics:

Symbol	Parameter	Max	Units
R_{eJA}	Thermal Resistance,Junction to ambient	50	°C/W

TMN10010MSI
N-Channel Enhancement Mosfet

Electrical Characteristics: ($T_A=25^\circ C$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250 \mu A$	100	---	---	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS}=0V, V_{DS}=80V$	---	---	10	μA
I_{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0A$	---	---	± 100	nA
On Characteristics						
$V_{GS(th)}$	GATE-Source Threshold Voltage	$V_{GS}=V_{DS}, I_D=250 \mu A$	1.2	---	2.9	V
$R_{DS(ON)}$	Drain-Source On Resistance ²	$V_{GS}=10V, I_D=5A$	---	75	90	$m\Omega$
		$V_{GS}=4.5V, I_D=3A$	---	95	110	$m\Omega$
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{DS}=50V, V_{GS}=0V, f=1MHz$	---	1008	---	pF
C_{oss}	Output Capacitance		---	31	--	
C_{rss}	Reverse Transfer Capacitance		---	22	---	
Switching Characteristics						
$t_{d(on)}$	Turn-On Delay Time	$V_{DS}=50V, I_D=5A,$ $R_{ENG}=3 \Omega, V_{GS}=10V$	---	37	---	ns
t_r	Rise Time		---	25.7	---	ns
$t_{d(off)}$	Turn-Off Delay Time		---	15	---	ns
t_f	Fall Time		---	8.7	---	ns
Q_{gs}	Total Gate Charge	$V_{GS}=10V, V_{DS}=50V,$ $I_D=5A$	---	16.3	---	nC
Q_{gd}	Gate-Source Charge		---	3.67	---	nC
Q_g	Gate-Drain "Miller" Charge		---	2.96	---	nC
Drain-Source Diode Characteristics						
V_{SD}	Diode Forward Voltage ²	$V_{GS}=0V, I_{SD}=1A$	---	---	1.2	V
I_s	Continuous Drain Current ^{1,5}	$VD=VG=0V$	---	---	10	A
I_{SM}	Pulsed Drain Current ^{2,5}		---	---	24	A

Notes:

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$
- 3.The EAS data shows Max. rating . The test condition is $V_{DD}=25V, V_{GS}=10V, L=1mH, I_{AS}=4.5A$
- 4.The power dissipation is limited by $150^\circ C$ junction temperature
- 5.The data is theoretically the same as I_D and I_{DM} , in real applications , should be limited by total power dissipation.

Typical Characteristics: ($T_A=25^\circ\text{C}$ unless otherwise noted)

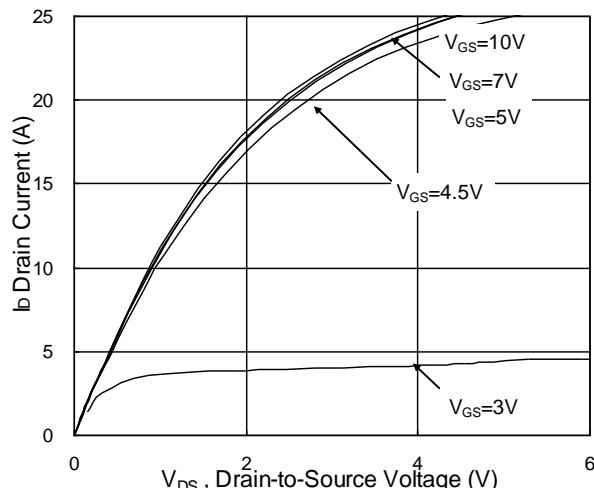


Fig.1 Typical Output Characteristics

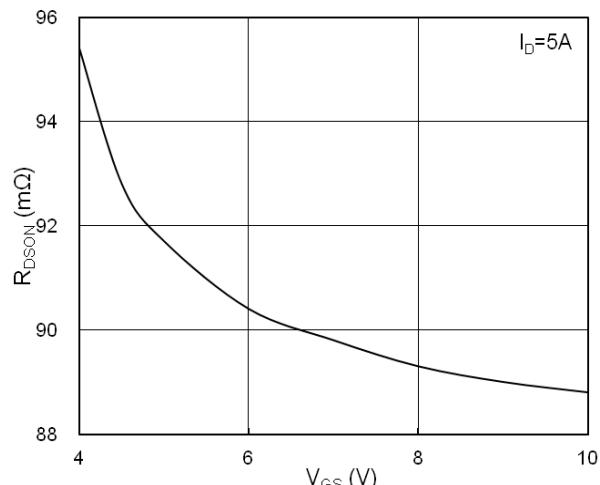


Fig.2 On-Resistance vs G-S Voltage

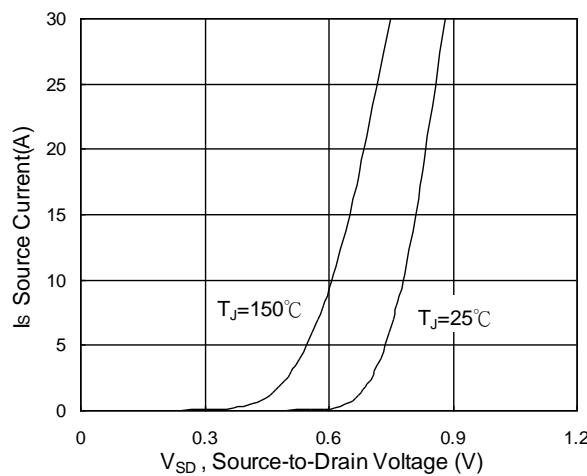


Fig.3 Source Drain Forward Characteristics

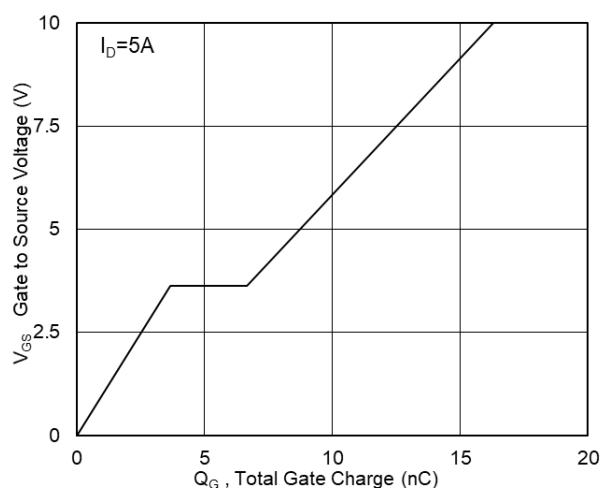


Fig.4 Gate-Charge Characteristics

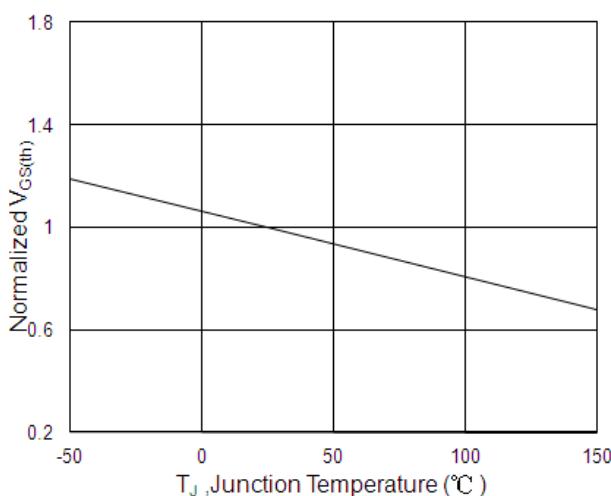


Fig.5 Normalized $V_{GS(th)}$ vs T_J

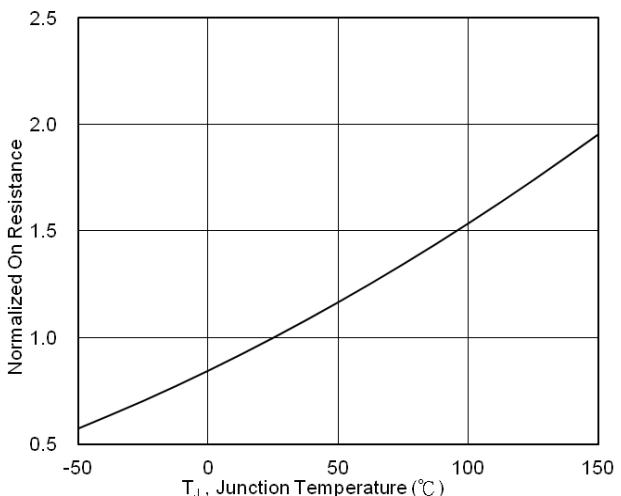


Fig.6 Normalized $R_{DS(on)}$ vs T_J

TMN10010MSI

N-Channel Enhancement Mosfet

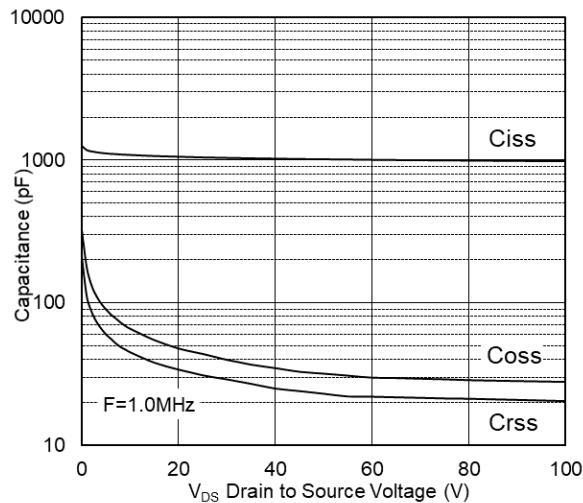


Fig.7 Capacitance

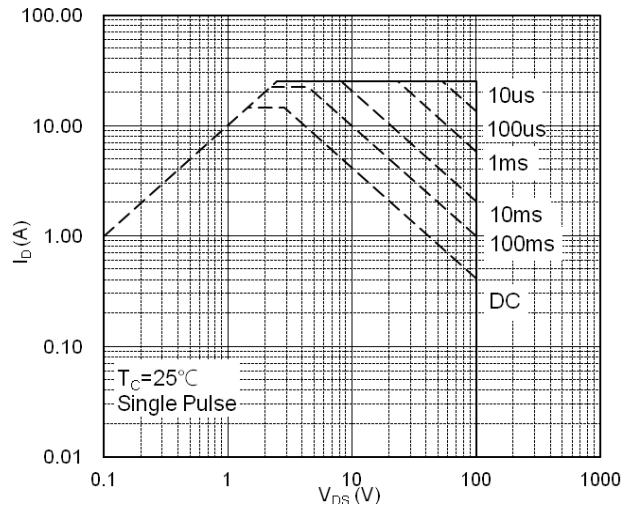


Fig.8 Safe Operating Area

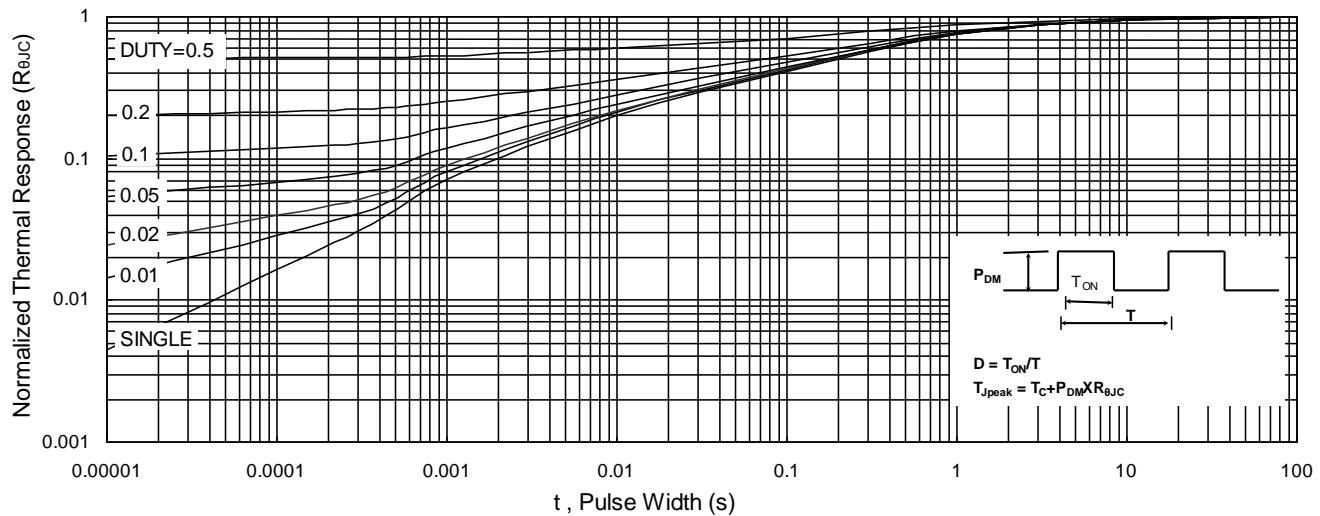
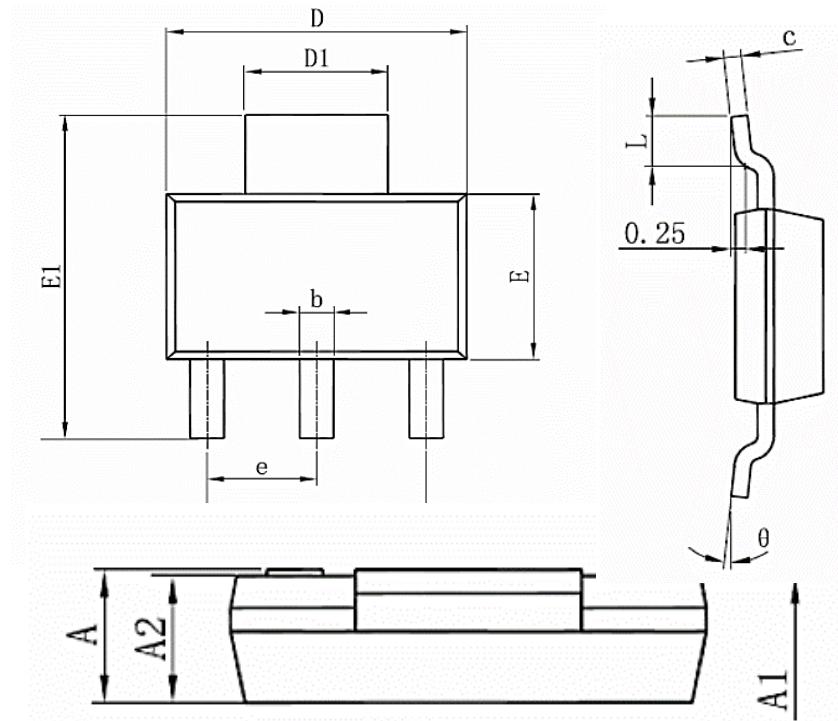


Fig.9 Normalized Maximum Transient Thermal Impedance

Package Mechanical Data:SOT-223-3L



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	1.52	1.8	0.06	0.049
A1	0.000	0.100	0.000	0.004
A2	1.5	1.7	0.059	0.045
b	0.66	0.82	0.026	0.032
c	0.25	0.35	0.010	0.014
D	6.2	6.4	0.244	0.252
D1	2.9	3.1	0.114	0.122
E	3.3	3.7	0.130	0.146
E1	6.83	7.07	0.269	0.278
e	2.300(BSC)		0.037(BSC)	
e1	4.500	4.700	0.177	0.185
L	0.900	1.15	0.035	0.045
θ	0°	10°	0°	10°